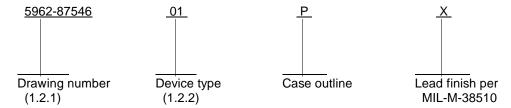
REVISIONS																				
LTR	DESCRIPTION							D,	ATE (Y	/R-MO-I	DA)		APPF	ROVE	)					
	ļ.												]				1			
REV																				
PAGE																				
REV																				
PAGE																				
REV STATUS	3		,	RE\	/	.,														
OF PAGE				PAC	ЭE		1	2	3	4	5	6	7	8	9	10				
DMIO NI/A				PRE	PAREI	) BY														
PMIC N/A				Ма	rcia B l	Kellehe	r				DE	EFENS					PLY C	ENTE	R	
MILITARY			CHE	CKED	BY				DAYTON, OHIO 45444											
DRAWING			Di Ce																	
THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE		APPI	ROVEI	D BY											HIGH-	SPEE	D,			
		N A	Hauck	•						FFER			NE DE	KIVER	ζ,					
		DRA	WING	APPRO	OVAL D	ΔTF														
DEPARTMENT OF DEFENSE		אול			ug 87	, 11 L		SIZE		CAG	E COD	F					- 10			
AMSC N/A		REV							A		<b>726</b>			59	62-	8/5	046			
				•																
										PAG	E	1	0	F	10					

1	SCO	D	
Ι.	$\circ$	Г	

1.1 <u>Scope</u>. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:



1.2.1 <u>Device type</u>. The device type shall identify the circuit function as follows:

Device type Generic number Circuit function

O1 9638 High speed dual differential line driver

1.2.2 Case outline. The case outline shall be as designated in appendix C of MIL-M-38510, and as follows:

Outline letter Case outline

P D-4 (8-lead, 1/4" x 3/8"), dual-in-line package

1.3 Absolute maximum ratings.

1.4 Recommended operating conditions.

Ambient operating temperature range (T<sub>A</sub>) .......... -55° C to +125° C

MILITARY DRAWING	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO		REV	PAGE 2

<sup>1/</sup> Rating applies to ambient temperature up to +125°C. Above +125°C ambient, derate linearly at 120°C/W.

#### 2. APPLICABLE DOCUMENTS

2.1 <u>Government specification and standard</u>. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

**SPECIFICATION** 

**MILITARY** 

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

**MILITARY** 

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

#### 3. REQUIREMENTS

- 3.1 <u>Item requirements</u>. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
  - 3.2.1 <u>Terminal connections</u>. The terminal connections shall be as specified on figure 1.
  - 3.2.2 Case outline. The case outline shall be in accordance with 1.2.2 herein.
- 3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full recommended ambient operating temperature range.
- 3.4 <u>Marking</u>. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein
- 3.5 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.6 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 <u>Notification of change</u>. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

MILITARY DRAWING	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO		REV	PAGE 3

Test Syn		Symbol Conditions $-55^{\circ}\text{C} \le \text{T}_{\text{C}} \le +125^{\circ}\text{C}$			Limits		Unit	
		unless other	unless otherwise specified 1/		Min	Max	1	
Input voltage HIGH 1/	V <sub>IH</sub>			1, 2, 3	2.0		V	
Input voltage LOW 1/	V <sub>IL</sub>			1, 2, 3		0.5	V	
Clamped input voltage	V <sub>IC</sub>	I <sub>II</sub> = -18 mA		1, 2, 3	-1.2		V	
Output voltage HIGH	V <sub>OH</sub>	V <sub>CC</sub> = 5.5 V,	I <sub>OH</sub> = -10 mA	1, 2, 3	2.5		V	
		V <sub>IH</sub> = 2.0 V, V <sub>IL</sub> = 0.5 V	I <sub>OH</sub> = -40 mA	1, 2, 3	2.0		V	
Output voltage LOW V <sub>OL</sub>		V <sub>IH</sub> = 2.0 V, V <sub>IL</sub> = 0.5 V, I <sub>OL</sub> = 30 mA		1, 2, 3		0.5	V	
Input current at maximum I <sub>I</sub> input voltage		V <sub>CC</sub> = 5.5 V, V <sub>IN</sub>	1, 2, 3		50	μΑ		
Input current HIGH	I <sub>IH</sub>	V <sub>CC</sub> = 5.5 V, V <sub>IH</sub> = 2.7 V		1, 2, 3		25	μΑ	
Input current LOW	I <sub>IL</sub>	V <sub>CC</sub> = 5.5 V, V <sub>IL</sub>	= 0.5 V	1, 2, 3	-200		μΑ	
Output short circuit current	I <sub>OS</sub>	V <sub>CC</sub> = 5.5 V, V <sub>C</sub>	<sub>0</sub> = 0 V	1, 2, 3	-150	-50	mA	
Terminated output voltage	$V_T, \nabla_T$	See figure 2		1, 2, 3	2.0		V	
Output balance $V_T$ - $\overline{V}_T$		See figure 2	1, 2, 3		0.4	V		
Output offset voltage $\underline{2}/$ $V_{OS}$ , $\nabla_{OS}$		See figure 2	1, 2, 3		3.0	V		
Output offest balance <u>3</u> / V <sub>OS</sub> -∇ <sub>OS</sub>		See figure 2, T <sub>A</sub> = +25°C		1		0.4	V	
Output leakage current	I <sub>CEX</sub>	V <sub>CC</sub> = 0 V -0.25 V ≤ V <sub>CEX</sub> ≤ 5		1, 2, 3	-150	150	μA	
Supply current (total) I <sub>CC</sub>		V <sub>CC</sub> = = 5.5 V, no inputs at 0 V	1, 2, 3		75	mA		

See footnotes at end of table.

MILITARY DRAWING	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO		REV	PAGE 4

TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Symbol Conditions $-55^{\circ}\text{C} \le T_{\text{C}} \le +125^{\circ}\text{C}$		Limits		Unit
		unless otherwise specified 1/	subgroups	Min	Max	
Propagation delay time, low to high level	<sup>t</sup> PLH	$C_L = 15 \text{ pF}, R_L = 100\Omega,$ $V_{CC} = 5.0 \text{ V}, T_A = +25^{\circ}\text{C}$ See figure 3	9		20	ns
Propagation delay time, high to low level	t <sub>PHL</sub>		9		20	ns
Fall time (90% to 10%)	t <sub>f</sub>		9		20	
Rise time (10% to 90%)	t <sub>r</sub>		9		20	ns

- 1/ Guaranteed by VOL and VOH tests.
- 2/ Guaranteed by maximum V<sub>CC</sub>.
- $\underline{3}$ / Guaranteed by V<sub>T</sub>- $\overline{V}$ <sub>T</sub> output balance.
- 3.8 <u>Verification and review</u>. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
  - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
  - a. Burn-in test (method 1015 of MIL-STD-883).
    - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
    - (2)  $T_A = +125^{\circ} C$ , minimum.
  - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

MILITARY DRAWING  DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
		REV	PAGE 5

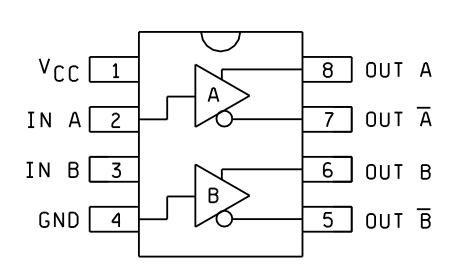


FIGURE 1. Terminal connections.

MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
		REV	PAGE 6

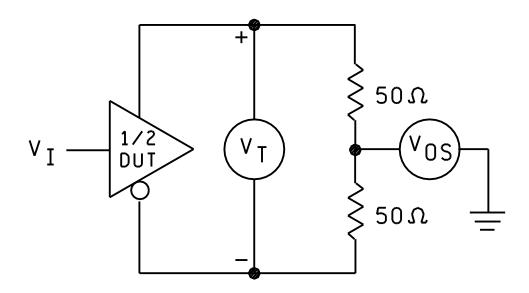
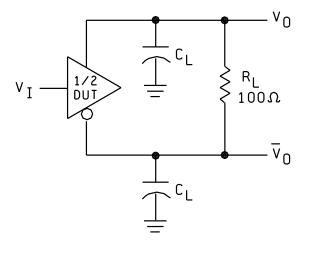
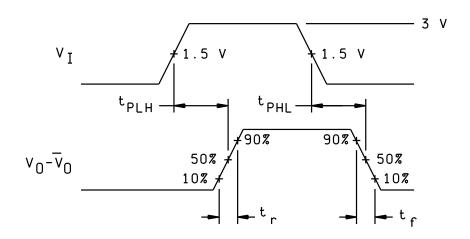


FIGURE 2. Terminated output voltage and output balance circuit.

MILITARY DRAWING	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO		REV	PAGE 7





# NOTES:

- 1. The pulse generator has the following characteristics;  $\rm Z_O = 50\Omega, \ PRR = 500 \ kHz.$
- 2.  $C_L$  includes probe and jig capacitance.

FIGURE 3. Switching times test circuit and waveforms.

MILITARY DRAWING	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO		REV	PAGE 8

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

### 4.3.1 Group A inspection.

- a. Tests shall be as specified in table II herein.
- b. Subgroups 4, 5, 6, 7, 8, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.

# 4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
  - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
  - (2)  $T_A = +125^{\circ} C$ , minimum.
  - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

TABLE II. Electrical test requirements.

TADLE II. <u>Liectifical test fec</u>	an on tone.
MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	1
Final electrical test parameters (method 5004)	1*, 2, 3, 9
Group A test requirements (method 5005)	1, 2, 3, 9
Groups C and D end-point electrical parameters (method 5005)	1

<sup>\*</sup> PDA applies to subgroup 1.

#### 5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

# 6. NOTES

6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO	SIZE <b>A</b>	CODE IDENT. NO. <b>67268</b>	DWG NO. 5962-87546
		REV	PAGE 9

- 6.2 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 <u>Comments</u>. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.
- 6.4 <u>Approved source of supply</u>. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military	Vendor	Vendor <u>1</u> /
drawing part	CAGE	similar part
number	number	number
5962-8754601PX	07263	µA9638RMQM

1/ <u>Caution</u>. Do not use this number for item acquisition ltems acquired by this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number

Vendor name and address

07263

Fairchild Semiconductor Corporation 313 Fairchild Drive

Mountain View, CA 94043

MILITARY DRAWING
DEFENSE ELECTRONICS SUPPLY CENTER
DAYTON, OHIO

SIZE CODE IDENT. NO. DWG NO. 5962-87546

REV PAGE 10